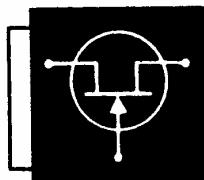


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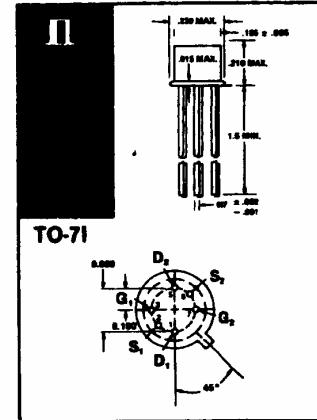
**ULTRA LOW NOISE  
DUAL MATCHED  
N-CHANNEL FIELD EFFECT TRANSISTOR**

**CD860**

**GEOMETRY 424**

**HIGH PERFORMANCE DIFFERENTIAL  
AMPLIFIERS**

- 1.4 nV/Hz<sup>1/2</sup> en @ 1 kHz
- Min. Operating Gm 25,000 μmho
- Matched VPO and Gm



The CD860 is a high GM/ID low noise junction F.E.T. for low level amplifier use. The min. GM of 25,000 assures a voltage gain of 25 min. with a 1K drain load. As a source follower it has a typical output impedance of 25 ohms. The 10mA operating point is easily held due to its low pinchoff voltage and is very close to its zero T.C. point for temperature stable operation.

**ELECTRICAL DATA ABSOLUTE MAXIMUM RATING**

PARAMETER	SYMBOL		UNITS
Drain to Source Voltage	BV <sub>DSD</sub>	20	Volts
Drain to Gate Voltage	BV <sub>GDO</sub>	20	Volts
Gate to Source Voltage	BV <sub>GSO</sub>	-20	Volts
D.C. Forward Gate Current	I <sub>GF</sub>	50	mA
Junction Temp. (Operating & Storage)	T <sub>J</sub>	-65°C to +200°C	
Power Dissipation (Free Air)	P <sub>D</sub>	400 mW	
Lead Temp. ( $\theta = 1/16'' \pm 1/32''$ from case)	T <sub>L</sub>	240° for 10 sec.	
Derating Factor (Free Air)	D <sub>F</sub>	2.3 mW/°C	

**ELECTRICAL CHARACTERISTICS: TA = 25°C (UNLESS OTHERWISE STATED)**

PARAMETER	SYMBOL	CONDITION	Min.	Typ.	Max.	UNITS
Gate Leakage Current	I <sub>GSS</sub>	V <sub>GS</sub> = -10V, V <sub>DS</sub> = 0	0.1	3.0	nA	
Gate Leakage Current	I <sub>GSS</sub>	V <sub>GS</sub> = -10V, V <sub>DS</sub> = 0, TA = 85°C	5	100	nA	
Zero Gate Voltage Drain Current	I <sub>DS</sub>	V <sub>GS</sub> = 10V, V <sub>DS</sub> = 0	10	100	mA	
Pinch-Off Voltage	V <sub>PO</sub>	V <sub>GS</sub> = 10V, I <sub>D</sub> = 0.1mA	0.3	1.5	3.0	Volts
Transconductance	g <sub>m</sub>	V <sub>GS</sub> = 10V, I <sub>D</sub> = 10mA, f = 1kHz	25	40		mmho
Input Capacitance	C <sub>IS</sub>	V <sub>GS</sub> = 10V, I <sub>D</sub> = 10mA, f = 140kHz	30	35		pfd
Reverse Xfer Cap	C <sub>RS</sub>	V <sub>GS</sub> = 10V, f = 140kHz	17	20		pfd
Gate to Drain Capacitance	C <sub>GD</sub>	V <sub>GS</sub> = -10V, f = 140kHz	20			pfd
Output Admittance	Y <sub>OS</sub>	V <sub>GS</sub> = 10V, I <sub>D</sub> = 10mA	50	100		μmho
Input Noise Voltage	en	V <sub>DS</sub> = 5V, I <sub>D</sub> = 10mA, f = 1kHz	1.4	2.0		nV/Hz <sup>1/2</sup>
Input Noise Voltage	en	V <sub>DS</sub> = 5V, I <sub>D</sub> = 10mA, f = 10Hz	6.0	10		nV/Hz <sup>1/2</sup>
Input Noise Voltage	en TOTAL	V <sub>DS</sub> = 5V, I <sub>D</sub> = 10mA, f = 10Hz to 20kHz	0.4	0.6		μVrms
Equivalent Open Ckt.		R <sub>source</sub> < 100KΩ, f = 1kHz		.01		pA/Hz <sup>1/2</sup>
Input Noise Current	i <sub>n</sub>				25	mV
VPO Match	V <sub>PO1</sub> -V <sub>PO2</sub>	V <sub>GS</sub> = 10V, I <sub>D</sub> = 0.1mA			5	%
Gm Match	G <sub>m1</sub> -G <sub>m2</sub>	V <sub>GS</sub> = 10V, I <sub>D</sub> = 10mA, f = 1kHz				